

# Francois Vurpillot

## List of Publications by Year in descending order

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109  
papers

3,339  
citations

172457

29  
h-index

155660

55  
g-index

113  
all docs

113  
docs citations

113  
times ranked

2018  
citing authors

#	ARTICLE	IF	CITATIONS
1	Trajectory overlaps and local magnification in three-dimensional atom probe. Applied Physics Letters, 2000, 76, 3127-3129.	3.3	390
2	Composition of Wide Bandgap Semiconductor Materials and Nanostructures Measured by Atom Probe Tomography and Its Dependence on the Surface Electric Field. Journal of Physical Chemistry C, 2014, 118, 24136-24151.	3.1	135
3	Reconstructing atom probe data: A review. Ultramicroscopy, 2013, 132, 19-30.	1.9	126
4	Atom probe tomography spatial reconstruction: Status and directions. Current Opinion in Solid State and Materials Science, 2013, 17, 236-247.	11.5	122
5	Chromatic Aberrations in the Field Evaporation Behavior of Small Precipitates. Microscopy and Microanalysis, 2008, 14, 561-570.	0.4	119
6	Correlated field evaporation as seen by atom probe tomography. Surface Science, 2007, 601, 536-543.	1.9	110
7	Structural analyses in three-dimensional atom probe: a Fourier transform approach. Journal of Microscopy, 2001, 203, 295-302.	1.8	109
8	A model accounting for spatial overlaps in 3D atom-probe microscopy. Ultramicroscopy, 2001, 89, 145-153.	1.9	104
9	Thermal response of a field emitter subjected to ultra-fast laser illumination. Journal Physics D: Applied Physics, 2009, 42, 125502.	2.8	101
10	The spatial resolution of 3D atom probe in the investigation of single-phase materials. Ultramicroscopy, 2000, 84, 213-224.	1.9	90
11	Depth resolution function of the laser assisted tomographic atom probe in the investigation of semiconductors. Journal of Applied Physics, 2009, 106, .	2.5	79
12	Improvement of multilayer analyses with a three-dimensional atom probe. Surface and Interface Analysis, 2004, 36, 552-558.	1.8	76
13	Correlation of Microphotoluminescence Spectroscopy, Scanning Transmission Electron Microscopy, and Atom Probe Tomography on a Single Nano-object Containing an InGaN/GaN Multiquantum Well System. Nano Letters, 2014, 14, 107-114.	9.1	70
14	Application of Fourier transform and autocorrelation to cluster identification in the three-dimensional atom probe. Journal of Microscopy, 2004, 216, 234-240.	1.8	63
15	Pragmatic reconstruction methods in atom probe tomography. Ultramicroscopy, 2011, 111, 1286-1294.	1.9	63
16	A new step towards the lattice reconstruction in 3DAP. Ultramicroscopy, 2003, 95, 223-229.	1.9	60
17	Investigation of w <sup>1/4</sup> stite (Fe <sup>1+O</sup> ) by femtosecond laser assisted atom probe tomography. Ultramicroscopy, 2011, 111, 584-588.	1.9	59
18	On the detection of multiple events in atom probe tomography. Ultramicroscopy, 2018, 189, 54-60.	1.9	59

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19	3D analysis of advanced nano-devices using electron and atom probe tomography. Ultramicroscopy, 2014, 136, 185-192.	1.9	52
20	Field evaporation: A kinetic Monte Carlo approach on the influence of temperature. Surface Science, 2011, 605, 2025-2031.	1.9	49
21	Statistical correction of atom probe tomography data of semiconductor alloys combined with optical spectroscopy: The case of Al <sub>0.25</sub> Ga <sub>0.75</sub> N. Journal of Applied Physics, 2016, 119, .	2.5	49
22	A new approach to the interpretation of atom probe field-ion microscopy images. Ultramicroscopy, 2001, 89, 137-144.	1.9	48
23	Understanding Atom Probe Tomography of Oxide-Supported Metal Nanoparticles by Correlation with Atomic-Resolution Electron Microscopy and Field Evaporation Simulation. Journal of Physical Chemistry Letters, 2014, 5, 1361-1367.	4.6	46
24	Three-dimensional nanoscale study of Al segregation and quantum dot formation in GaAs/AlGaAs core-shell nanowires. Applied Physics Letters, 2014, 105, .	3.3	45
25	Simulation of field-induced molecular dissociation in atom-probe tomography: Identification of a neutral emission channel. Physical Review A, 2017, 95, .	2.5	43
26	Application of Delaunay tessellation for the characterization of solute-rich clusters in atom probe tomography. Ultramicroscopy, 2011, 111, 200-206.	1.9	40
27	Analysis of Radiation Damage in Light Water Reactors: Comparison of Cluster Analysis Methods for the Analysis of Atom Probe Data. Microscopy and Microanalysis, 2017, 23, 366-375.	0.4	40
28	Clustering and Local Magnification Effects in Atom Probe Tomography: A Statistical Approach. Microscopy and Microanalysis, 2010, 16, 643-648.	0.4	37
29	Three dimensional imaging and analysis of a single nano-device at the ultimate scale using correlative microscopy techniques. Applied Physics Letters, 2015, 106, .	3.3	31
30	A chemical composition correction model for nanoclusters observed by APT - Application to ODS steel nanoparticles. Journal of Nuclear Materials, 2018, 505, 240-248.	2.7	30
31	Some aspects of the silicon behaviour under femtosecond pulsed laser field evaporation. Ultramicroscopy, 2007, 107, 767-772.	1.9	29
32	A model to predict image formation in Atom probeTomography. Ultramicroscopy, 2013, 132, 152-157.	1.9	27
33	Energy deficit of pulsed-laser field-ionized and field-emitted ions from non-metallic nano-tips. Journal of Applied Physics, 2014, 115, .	2.5	27
34	A Meshless Algorithm to Model Field Evaporation in Atom Probe Tomography. Microscopy and Microanalysis, 2015, 21, 1649-1656.	0.4	27
35	Dissociation Dynamics of Molecular Ions in High dc Electric Field. Journal of Physical Chemistry A, 2016, 120, 3654-3662.	2.5	26
36	Green Electroluminescence from Radial <i>m</i> -Plane InGaN Quantum Wells Grown on GaN Wire Sidewalls by Metal-Organic Vapor Phase Epitaxy. ACS Photonics, 2018, 5, 4330-4337.	6.6	26

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37	Imaging individual solute atoms at crystalline imperfections in metals. <i>New Journal of Physics</i> , 2019, 21, 123020.	2.9	26
38	Investigation at the atomic scale of the Co spatial distribution in Zn(Co)O magnetic semiconductor oxide. <i>Journal of Applied Physics</i> , 2009, 105, .	2.5	24
39	Unraveling the Metastability of $C_{n+2}^{n+4}$ ( $n = 2\text{--}4$ ) Clusters. <i>Journal of Physical Chemistry Letters</i> , 2019, 10, 581-588.	4.6	24
40	Improved ion detection efficiency of microchannel plate detectors. <i>Review of Scientific Instruments</i> , 2002, 73, 1734-1740.	1.3	23
41	Optical and thermal processes involved in ultrafast laser pulse interaction with a field emitter. <i>Ultramicroscopy</i> , 2007, 107, 713-719.	1.9	23
42	Evidence of atomic-scale arsenic clustering in highly doped silicon. <i>Journal of Applied Physics</i> , 2009, 106, .	2.5	23
43	Numerical study of femtosecond laser-assisted atom probe tomography. <i>Applied Physics A: Materials Science and Processing</i> , 2013, 110, 703-707.	2.3	23
44	Interpreting nanovoids in atom probe tomography data for accurate local compositional measurements. <i>Nature Communications</i> , 2020, 11, 1022.	12.8	23
45	Atom probe tomography analysis of SiGe fins embedded in SiO <sub>2</sub> : Facts and artefacts. <i>Ultramicroscopy</i> , 2017, 179, 100-107.	1.9	22
46	Composition Metrology of Ternary Semiconductor Alloys Analyzed by Atom Probe Tomography. <i>Journal of Physical Chemistry C</i> , 2018, 122, 16704-16714.	3.1	22
47	Laser-assisted atom probe tomography and nanosciences. <i>International Journal of Materials Research</i> , 2008, 99, 454-460.	0.3	21
48	Impact of local electrostatic field rearrangement on field ionization. <i>Journal Physics D: Applied Physics</i> , 2018, 51, 105601.	2.8	20
49	Ultrafast ion emission from metallic tip excited by femtosecond laser pulses. <i>Applied Physics Letters</i> , 2006, 89, 251903.	3.3	17
50	Conditions to cancel the laser polarization dependence of a subwavelength tip. <i>Applied Physics Letters</i> , 2009, 94, .	3.3	17
51	Electronic structure and stability of the SiO <sub>2</sub> <sup>+</sup> dications produced in tomographic atom probe experiments. <i>Journal of Chemical Physics</i> , 2017, 147, 164301.	3.0	17
52	Coupling atom probe tomography and photoluminescence spectroscopy: Exploratory results and perspectives. <i>Ultramicroscopy</i> , 2013, 132, 75-80.	1.9	16
53	True Atomic-Scale Imaging in Three Dimensions: A Review of the Rebirth of Field-Ion Microscopy. <i>Microscopy and Microanalysis</i> , 2017, 23, 210-220.	0.4	16
54	An Automated Computational Approach for Complete In-Plane Compositional Interface Analysis by Atom Probe Tomography. <i>Microscopy and Microanalysis</i> , 2019, 25, 389-400.	0.4	16

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55	Reflections on the Spatial Performance of Atom Probe Tomography in the Analysis of Atomic Neighborhoods. <i>Microscopy and Microanalysis</i> , 2022, 28, 1116-1126.	0.4	16
56	New Atom Probe Tomography Reconstruction Algorithm for Multilayered Samples: Beyond the Hemispherical Constraint. <i>Microscopy and Microanalysis</i> , 2017, 23, 247-254.	0.4	15
57	Laser-assisted atom probe tomography investigation of magnetic FePt nanoclusters: First experiments. <i>Journal of Alloys and Compounds</i> , 2012, 517, 40-44.	5.5	14
58	Carrier Localization in GaN/AlN Quantum Dots As Revealed by Three-Dimensional Multimicroscopy. <i>Nano Letters</i> , 2017, 17, 4261-4269.	9.1	14
59	Ultrafast emission of ions during laser ablation of metal for 3D atom probe. <i>Applied Surface Science</i> , 2009, 255, 5154-5158.	6.1	12
60	Dynamic evolution and fracture of multilayer field emitters in atom probe tomography: a new interpretation. <i>EPJ Applied Physics</i> , 2015, 72, 21001.	0.7	12
61	Pulse shaping optimization for improving atom probe tomography. <i>International Journal of Mass Spectrometry</i> , 2015, 386, 47-53.	1.5	12
62	Advanced volume reconstruction and data mining methods in atom probe tomography. <i>MRS Bulletin</i> , 2016, 41, 46-52.	3.5	12
63	Simulation tools for atom probe tomography: A path for diagnosis and treatment of image degradation. <i>Materials Characterization</i> , 2018, 146, 336-346.	4.4	12
64	Characterization of Pd and Pd@Au core-shell nanoparticles using atom probe tomography and field evaporation simulation. <i>Journal of Alloys and Compounds</i> , 2020, 831, 154721.	5.5	12
65	Challenges in the study of Fe/MgO/Fe interfaces using 3D Atom Probe. <i>Thin Solid Films</i> , 2015, 589, 38-46.	1.8	11
66	Multi-excitonic emission from Stranski-Krastanov GaN/AlN quantum dots inside a nanoscale tip. <i>Applied Physics Letters</i> , 2017, 111, .	3.3	11
67	Dissociation of GaN <sub>2</sub> <sup>+</sup> and AlN <sub>2</sub> <sup>+</sup> in APT: Analysis of experimental measurements. <i>Journal of Chemical Physics</i> , 2018, 149, 134311.	3.0	11
68	Interpreting the Presence of an Additional Oxide Layer in Analysis of Metal Oxidesâ€“Metal Interfaces in Atom Probe Tomography. <i>Journal of Physical Chemistry C</i> , 2019, 123, 1313-1319.	3.1	11
69	The New Laser assisted Wide Angle Tomographic Atom Probe. <i>Microscopy and Microanalysis</i> , 2006, 12, 1726-1727.	0.4	10
70	Quantitative investigation of SiGeC layers using atom probe tomography. <i>Ultramicroscopy</i> , 2015, 150, 23-29.	1.9	10
71	Preferential Evaporation in Atom Probe Tomography: An Analytical Approach. <i>Microscopy and Microanalysis</i> , 2020, 26, 689-698.	0.4	10
72	A model to predict image formation in the three-dimensional field ion microscope. <i>Computer Physics Communications</i> , 2021, 260, 107317.	7.5	9

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73	Enhancing Element Identification by Expectationâ€“Maximization Method in Atom Probe Tomography. <i>Microscopy and Microanalysis</i> , 2019, 25, 367-377.	0.4	8
74	Enhanced dynamic reconstruction for atom probe tomography. <i>Ultramicroscopy</i> , 2019, 197, 72-82.	1.9	8
75	Analysis of nanoscale fluid inclusions in geomaterials by atom probe tomography: Experiments and numerical simulations. <i>Ultramicroscopy</i> , 2020, 218, 113092.	1.9	8
76	Super-resolution Optical Spectroscopy of Nanoscale Emitters within a Photonic Atom Probe. <i>Nano Letters</i> , 2020, 20, 8733-8738.	9.1	8
77	3D atom probe assisted by femtosecond laser pulses. <i>Applied Physics A: Materials Science and Processing</i> , 2008, 93, 995-1003.	2.3	7
78	Ion energy spread in laser-assisted atom probe tomography. <i>Europhysics Letters</i> , 2015, 109, 37009.	2.0	7
79	Dissociation of GaN <sub>2</sub> <sup>+</sup> and AlN <sub>2</sub> <sup>+</sup> in APT: Electronic structure and stability in strong DC field. <i>Journal of Chemical Physics</i> , 2018, 149, 134310.	3.0	7
80	Spatial and Compositional Biases Introduced by Position Sensitive Detection Systems in APT: A Simulation Approach. <i>Microscopy and Microanalysis</i> , 2019, 25, 418-424.	0.4	7
81	Revealing atomic-scale vacancy-solute interaction in nickel. <i>Scripta Materialia</i> , 2021, 203, 114036.	5.2	7
82	Structural investigation of TbCo <sub>2</sub> /Fe magnetostrictive thin films by tomographic atom probe and MÃ“ssbauer spectrometry. <i>Journal of Magnetism and Magnetic Materials</i> , 2007, 310, 2215-2216.	2.3	6
83	A Mesoscopic Field Evaporation Model. <i>Microscopy and Microanalysis</i> , 2019, 25, 286-287.	0.4	6
84	Dynamic Effects in Voltage Pulsed Atom Probe. <i>Microscopy and Microanalysis</i> , 2020, 26, 1133-1146.	0.4	6
85	Detecting Dissociation Dynamics of Phosphorus Molecular Ions by Atom Probe Tomography. <i>Journal of Physical Chemistry A</i> , 2020, 124, 10977-10988.	2.5	6
86	Development of an Energy-Sensitive Detector for the Atom Probe Tomography. <i>Microscopy and Microanalysis</i> , 2022, 28, 1076-1091.	0.4	6
87	Ultrafast Laser Assisted Field Evaporation and Atom Probe Tomography Applications. <i>Journal of Physics: Conference Series</i> , 2007, 59, 132-135.	0.4	5
88	Nanometer Scale Tomographic Investigation of Fine Scale Precipitates in a CuFeNi Granular System by Three-Dimensional Field Ion Microscopy. <i>Microscopy and Microanalysis</i> , 2012, 18, 1129-1134.	0.4	5
89	ANALYSIS OF EXCITATION PULSED SIGNAL PROPAGATION FOR ATOM PROBE TOMOGRAPHY SYSTEM. <i>Progress in Electromagnetics Research Letters</i> , 2014, 47, 61-70.	0.7	5
90	Influence of field conditions on quantitative analysis of single crystal thorium dioxide by atom probe tomography. <i>Ultramicroscopy</i> , 2021, 220, 113167.	1.9	5

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91	Quantitative analysis of Si/SiGeC superlattices using atom probe tomography. Ultramicroscopy, 2015, 159, 223-231.	1.9	4
92	Optimizing Atom Probe Analysis with Synchronous Laser Pulsing and Voltage Pulsing. Microscopy and Microanalysis, 2017, 23, 221-226.	0.4	4
93	Development of Wide Field of View Three-Dimensional Field Ion Microscopy and High-Fidelity Reconstruction Algorithms to the Study of Defects in Nuclear Materials. Microscopy and Microanalysis, 2021, 27, 365-384.	0.4	4
94	Surface Microscopy of Atomic and Molecular Hydrogen from Field-Evaporating Semiconductors. Journal of Physical Chemistry C, 2021, 125, 17078-17087.	3.1	4
95	Dissociation of Molecular Ions During the DC Field Evaporation ZnO in Atom Probe Tomography. Microscopy and Microanalysis, 2016, 22, 662-663.	0.4	2
96	Kronâ€“Branin modelling of ultra-short pulsed signal microelectrode. EPJ Applied Physics, 2018, 81, 21001.	0.7	2
97	Analytical Three-Dimensional Field Ion Microscopy of an Amorphous Glass FeBSi. Microscopy and Microanalysis, 2021, , 1-9.	0.4	2
98	Nanoscale Microstructural and Chemical Analysis of SiO <sub>2</sub> â€“Zn <sub>1â€“x</sub> Al <sub>x</sub> O Nanocomposites: Towards a Better Understanding of Si and Al Substitution in ZnO. Journal of the American Ceramic Society, 2015, 98, 3948-3955.	3.8	1
99	Nanoscale photoconductive switching effect applied to atom probe tomography. Europhysics Letters, 2016, 116, 27002.	2.0	1
100	Atomistic Simulations of Surface Effects Under High Electric Fields. Microscopy and Microanalysis, 2017, 23, 644-645.	0.4	1
101	Characterization of a High Voltage and High Frequency pulse generator configuration for Atom Probe. , 2020, , .		1
102	Design of A Multistage Marx Generator topology based on SiC-MOSFET Device for Atomic Probe Tomography Applications. , 2020, , .		1
103	A Tomographic Atom Probe laser assisted by a flexible optical system. Microscopy and Microanalysis, 2021, 27, 1260-1261.	0.4	1
104	3D Atom Probe: Chemical Analysis With (Near) Atomic Resolution. Microscopy and Microanalysis, 2003, 9, 568-569.	0.4	0
105	Bridging the Gap between the Modeling Approach and the Experiment in Atom Probe Tomography. Microscopy and Microanalysis, 2015, 21, 37-38.	0.4	0
106	Field Evaporation Behavior of Metal Oxide/Metal Interfaces. Microscopy and Microanalysis, 2016, 22, 678-679.	0.4	0
107	Recent Reconstruction Developments in IVAS. Microscopy and Microanalysis, 2017, 23, 638-639.	0.4	0
108	Reconstructing APT Datasets: Challenging the Limits of the Possible. Microscopy and Microanalysis, 2017, 23, 640-641.	0.4	0

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109	Interpreting Voids in Atom Probe Tomography Data via Experiment and Theory. Microscopy and Microanalysis, 2019, 25, 290-291.	0.4	0